



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Frederick A. Enko
Serial No. : 10/747,622
Filed : December 30, 2003
Title : INFLATABLE PUZZLE STORAGE

Art Unit : 3711
Examiner : Jerrold D. Johnson

MAIL STOP RCE

Commissioner for Patents
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Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

This filing is being made with the filing of a Request for Continued Examination. No fee is required.

Respectfully submitted,

Date: November 17, 2005

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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 06181-930001	Application No. 10/747,622
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Frederick A. Enko	
		Filing Date December 30, 2003	Group Art Unit 3711

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	2002/0163126 A1	11/07/2002	Caldwell			
	AB	6,364,116 B1	04/02/2002	Ng			
	AC	5,651,547	07/29/1997	Rannelli			
	AD	5,669,092	09/23/1997	Lin			
	AE	5,642,883	07/01/1997	Rioux			
	AF	5,538,248	07/23/1996	Shillito et al			
	AG	5,105,944	04/21/1992	Ingalls et al.			
	AH	4,505,424	03/19/1985	Chappars			
	AI	3,704,892	12/05/1972	Moravick et al.			
	AJ						
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	AR						
	AS						
	AT						
	AU						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AV							

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	